

Product Name: ZX132DS10 Differential paired Samtec Probe Breakout Adapter E5378A E5379A E5385A Logic Analyzer probe

Product Description: Differentially paired Samtec Probe breakout adapter, compatible with E5378A E5379A logic analyzer probe pinout assignments using 0.1" pitch header. 50pins per 2 rows → 100 pins. Using Samtec's Basic Blade & Beam Header BTH connector series ASP65267-02. It can be used with Single ended probe such as E5346A. Reserved Probe pins are accessible via 0402 SMD pads for applying filter circuit or testing, see Note 2.

- All differential pairs match Clkp-Clkn trace length
- Designed in 4 layer PCBoard
- Improved signal integrity and crosstalk.
- 90 Ω differential pair trace impedance, matching connector's impedance
- Reference plane impedance 50Ω for DC to 8GHz bandwidth applications for single ended applications.

GND test points for easy access – GND Test point must be connected to system GND
GND test points is tied to 2 inner layer GND planes

Application: Agilent logic Analyzer probes **E5385A E5378A E5379A Logic Analyzer probe**, Pre-Bringup, Bringup, characterization, testing, emulation, development, modular design evaluations / functional vlidation

Mates with : Samtec ASP-65067-01 as well as BSH050 connector series
Designed to meet Agilent Logic Analyzer Samtec probe. ZX132DS10 can be used with flying leads probes E5381A or similar

Pitch: 0.50mm (0.0197") High Speed connector

Headers: 0.1" (2.54mm) center, 0.025" (0.64mm) SQ with 0.23" (5.6mm) post height

ZX132DS10 pin configuration

Layer												
Bottom	Headers	J3	D0- 7	D2- 15	D4- 23	D6- 31	D8- 39	D10+ 47	D12+ 55	D14- 63	79- CLKn	87
			D0+ 8	D2+ 16	D4+ 24	D6+ 32	D8+40	D10- 48	D12- 56	D14+ 64	80+ Clkp	88
Top	Headers	J2	D1 + 12	D3+ 20	D5+ 28	D7+ 36	D9+ 44	D11+ 52	D13+60	D15+ 68	84	GND
			D1- 11	D3- 19	D5- 27	D7- 35	D9- 43	D11- 51	D13- 59	D15- 67	83	GND
TOP	BTH	J1										
BOTTOM												

Header numbering refers to the Samtec connector pin number

BTH footprint is identical to ASP65267-02, it mates with BSH050 and ASP-65067-01

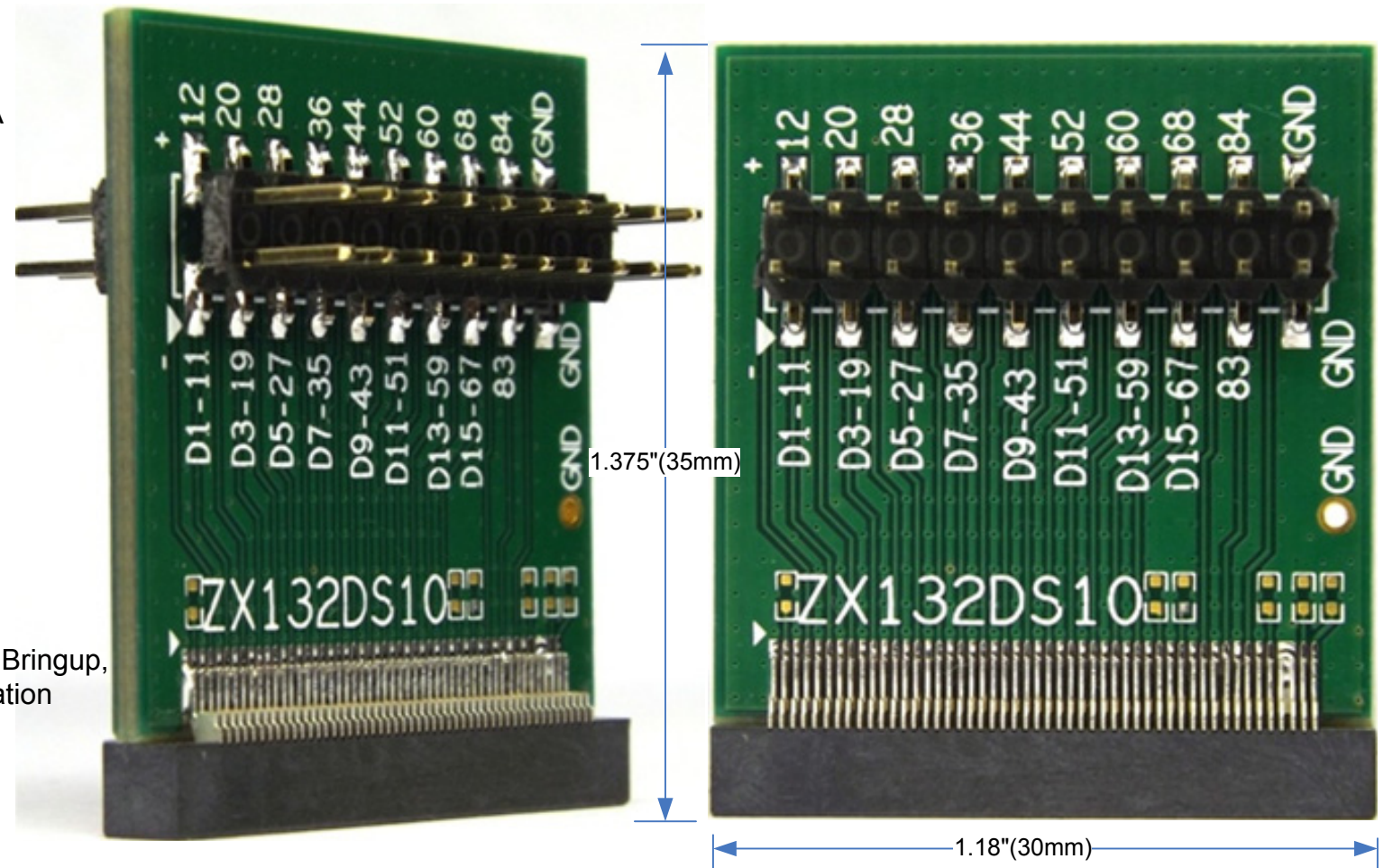
Dx- is referred to Negative signal of differential pair. Dx+ is the positive signal of differential pair.

Ground pins	1	5	9	13	17	21	25	29	33	37	41	45	49	53	57	61	65	69	73	77	81	85	89	93	95
	2	6	10	14	18	22	26	30	34	38	42	46	50	54	58	62	66	70	74	78	82	86	90	94	96

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NOTES:

- 1- The GND test point is connected to 2 internal GND layers. Please apply system ground for improved signal measurements
- 2- 0402 SMD Pads are available accessing reserved Samtec connector pins, see table below:

Accessible pins	3	71	75	91	97	99
	4	72	76	92	98	100



Note

ALL ZEBAX products are RoHS compliant and Lead Free unless otherwise indicated.

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SPECIFIED DIMENSIONS ARE INCHES (MM). ROHS COMPLIANT	ASSEMBLY DRAWING	
	ITEM: ZX132DS10 Samtec Probe	
DESCRIPTION: Differential paired Samtec Probe Breakout Adapter E5378A E5379A Logic Analyzer probe		
CHECKED: M. MARINA	DRAWN: SLAVIK	REVISION: 1.0 SHEET: 1 OF 1